BFG10; BFG10/X

NPN 2 GHz RF power transistor

Rev. 05 — 22 November 2007 Product data sheet

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NPN 2 GHz RF power transistor BFG10; BFG10/X

FEATURES

- High power gain
- High efficiency
- Small size discrete power amplifier
- 1.9 GHz operating area
- Gold metallization ensures excellent reliability.

APPLICATIONS

- Common emitter class-AB operation in hand-held radio equipment at 1.9 GHz.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in plastic, 4-pin dual-emitter SOT143 package.

PINNING

PIN	DESCRIPTION
BFG10 (see Fig.1)	
1	collector
2	base
3	emitter
4	emitter
BFG10/X (see Fig.1)	
1	collector
2	emitter
3	base
4	emitter

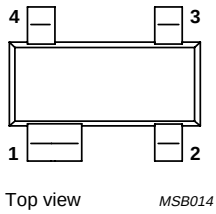


Fig.1 SOT143.

MARKING

TYPE NUMBER	CODE
BFG10	%MS
BFG10/X	%MT

QUICK REFERENCE DATA

RF performance at T_{amb} = 25 °C in a common-emitter test circuit (see Fig.7).

MODE OF OPERATION	f (GHz)	V_{CE} (V)	P_L (mW)	G_p (dB)	η_c (%)
Pulsed, class-AB, duty cycle: < 1 : 8	1.9	3.6	200	≥5	≥50

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter	–	20	V
V_{CEO}	collector-emitter voltage	open base	–	8	V
V_{EBO}	emitter-base voltage	open collector	–	2.5	V
I_C	collector current (DC)		–	250	mA
$I_{C(AV)}$	average collector current		–	250	mA
P_{tot}	total power dissipation	up to T_s = 60 °C; see Fig.2; note 1	–	400	mW
T_{stg}	storage temperature		–65	+150	°C
T_j	junction temperature		–	175	°C

Note

1. T_s is the temperature at the soldering point of the collector pin.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j\text{-}s}$	thermal resistance from junction to soldering point	up to T_s = 60 °C; note 1; P_{tot} = 400 mW	290	K/W

Note

1. T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{(BR)CBO}$	collector-base breakdown voltage	open emitter; I_C = 0.1 mA	20	–	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	open base; I_C = 5 mA	8	–	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector; I_E = 0.1 mA	2.5	–	V
I_{CES}	collector leakage current	V_{CE} = 5 V; V_{BE} = 0	–	100	µA
h_{FE}	DC current gain	I_C = 50 mA; V_{CE} = 5 V	25	–	
C_c	collector capacitance	$I_E = i_e$ = 0; V_{CB} = 3.6 V; f = 1 MHz	–	3	pF
C_{re}	feedback capacitance	I_C = 0; V_{CE} = 3.6 V; f = 1 MHz	–	2	pF

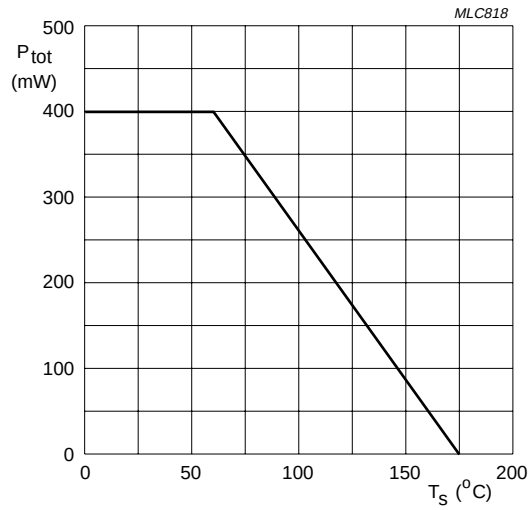
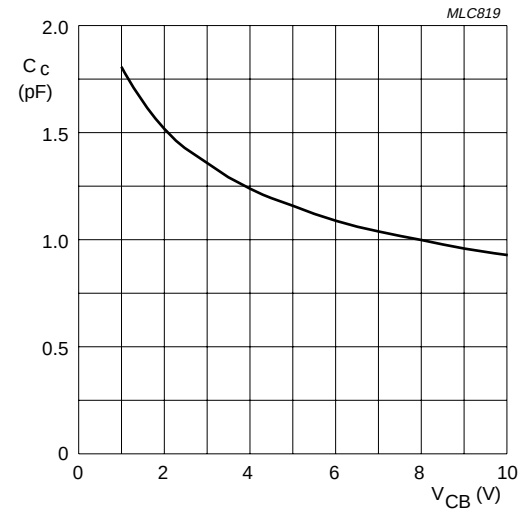


Fig.2 Power derating curve



I_C = 0; f = 1 MHz.

Fig.3 Collector capacitance as a function of collector-base voltage; typical values.

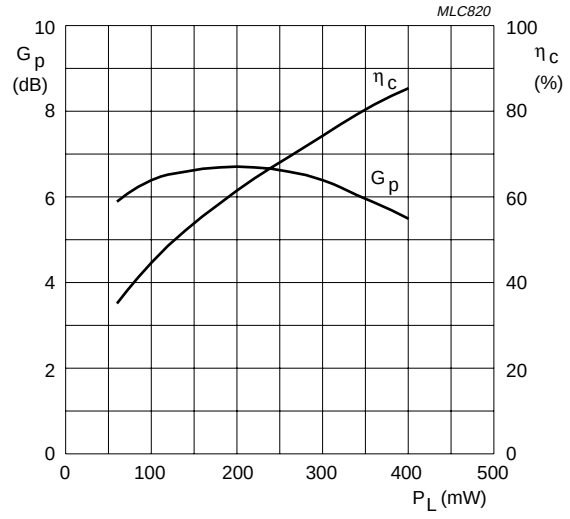
APPLICATION INFORMATION

RF performance at T_{amb} = 25 °C in a common-emitter test circuit (see Fig.7).

MODE OF OPERATION	f (GHz)	V_{CE} (V)	I_{CQ} (mA)	P_L (mW)	G_p (dB)	η_c (%)
Pulsed, class-AB, duty cycle: < 1 : 8	1.9	3.6	1	200	>5 typ. 7	>50 typ. 60

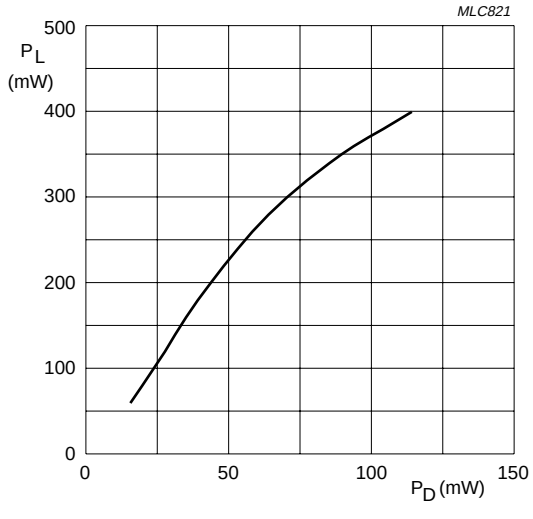
Ruggedness in class-AB operation

The BFG10 is capable of withstanding a load mismatch corresponding to VSWR = 8 : 1 through all phases, at rated output power under pulsed conditions up to a supply voltage of 7 V, f = 1.9 GHz and a duty cycle of 1 : 8.



Pulsed, class-AB operation.
V_{CE} = 3.6 V; V_{BE} = 0.65 V; f = 1.9 GHz; duty cycle < 1 : 8.
Circuit optimized for P_L = 200 mW.

Fig.4 Power gain and efficiency as functions of load power; typical values.

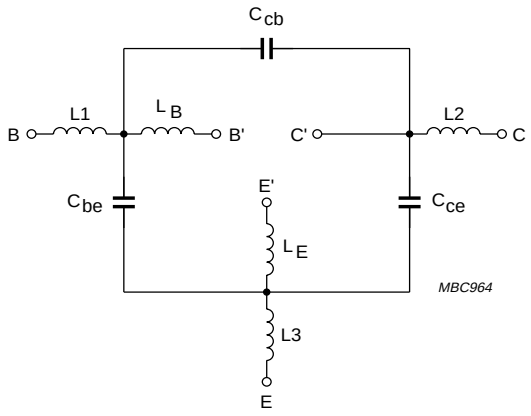


Pulsed, class-AB operation.
V_{CE} = 3.6 V; V_{BE} = 0.65 V; f = 1.9 GHz; duty cycle < 1 : 8.
Circuit optimized for P_L = 200 mW.

Fig.5 Load power as a function of drive power; typical values.

SPICE parameters for the BFG10 crystal

SEQUENCE No.	PARAMETER	VALUE	UNIT
1	IS	2.714	fA
2	BF	102.8	–
3	NF	0.998	–
4	VAF	28.12	V
5	IKF	6.009	A
6	ISE	403.2	pA
7	NE	2.937	–
8	BR	31.01	–
9	NR	0.999	–
10	VAR	2.889	V
11	IKR	0.284	A
12	ISC	1.487	fA
13	NC	1.100	–
14	RB	3.500	Ω
15	IRB	1.000	μA
16	RBM	3.500	Ω
17	RE	0.217	Ω
18	RC	0.196	Ω
19(1)	XTB	0.000	–
20(1)	EG	1.110	eV
21(1)	XTI	3.000	–
22	CJE	5.125	pF
23	VJE	0.600	V
24	MJE	0.367	–
25	TF	12.07	ps
26	XTF	99.40	–
27	VTF	7.220	V
28	ITF	3.950	A
29	PTF	0.000	deg
30	CJC	2.327	pF
31	VJC	0.668	V
32	MJC	0.398	–
33	XCJC	0.160	–
34(1)	TR	0.000	ns
35(1)	CJS	0.000	F
36(1)	VJS	750.0	mV
37(1)	MJS	0.000	–
38	FC	0.652	–



$QL_B = 50$; $QL_E = 50$; $QL_{B,E}(f) = QL_{B,E}\sqrt{(f/f_c)}$;
f_c = scaling frequency = 100 MHz.

Fig.6 Package equivalent circuit SOT143.

List of components (see Fig.6)

DESIGNATION	VALUE	UNIT
C_{be}	84	fF
C_{cb}	17	fF
C_{ce}	191	fF
L1	0.12	nH
L2	0.21	nH
L3	0.06	nH
L_B	0.95	nH
L_E	0.40	nH

Note

1. These parameters have not been extracted, the default values are shown.

Test circuit information

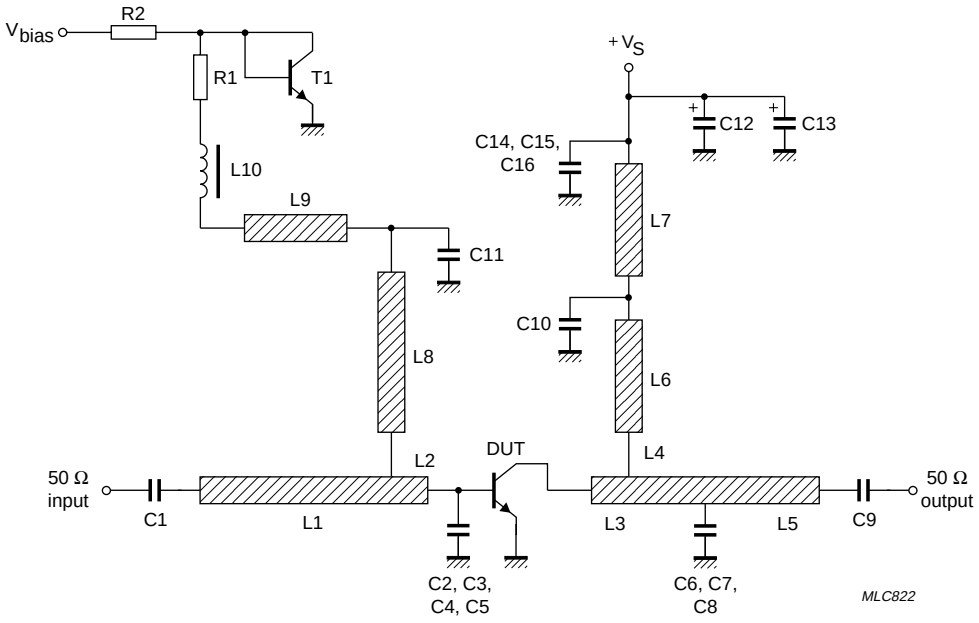


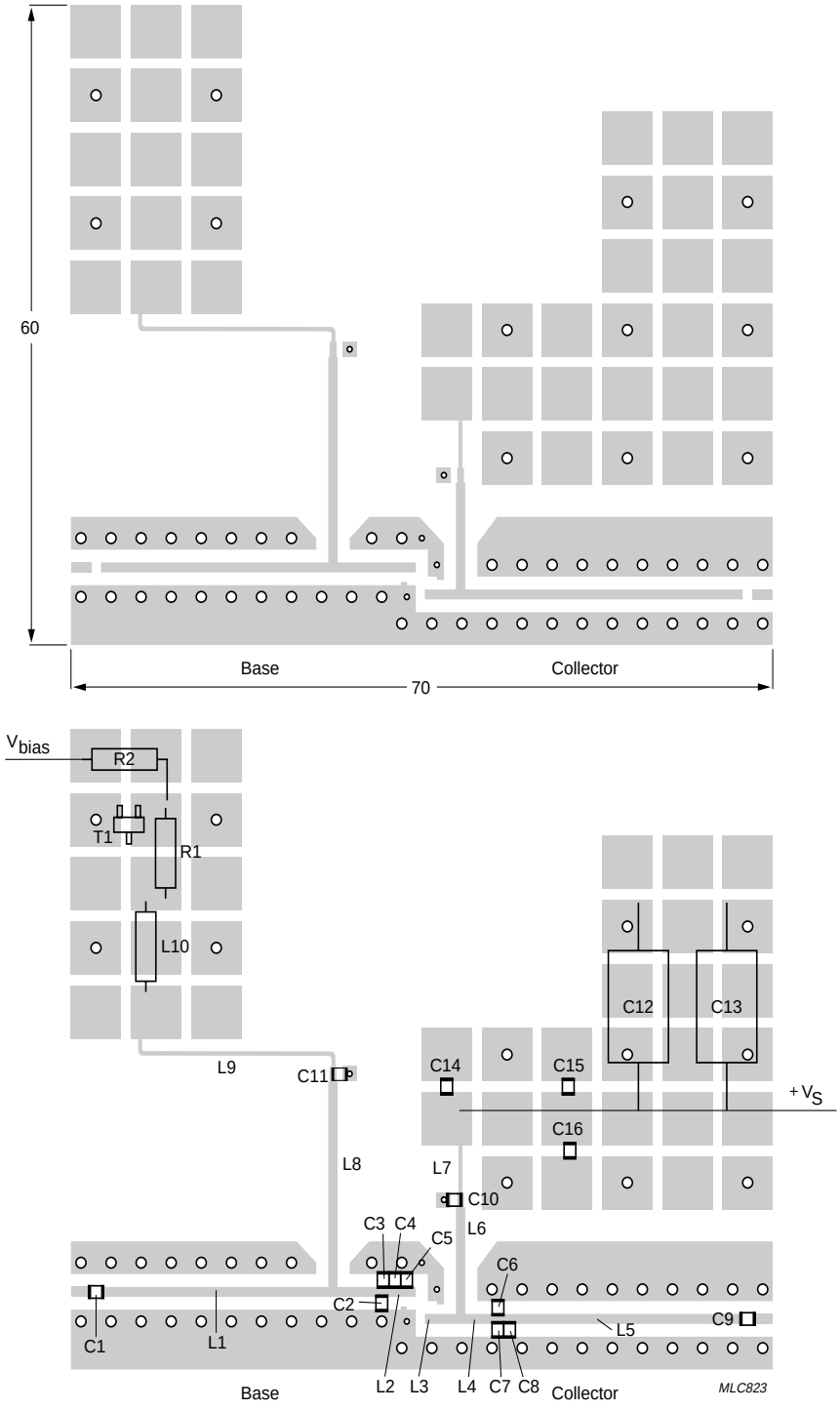
Fig.7 Common-emitter test circuit for class-AB operation at 1.9 GHz.

List of components used in test circuit (see Fig.7)

COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE No.
C1, C9, C10, C11	multilayer ceramic chip capacitor; note 1	24 pF		
C2, C3, C4, C5, C6, C7	multilayer ceramic chip capacitor; note 1	0.86 pF		
C8	multilayer ceramic chip capacitor; note 1	1.1 pF		
C12, C13	electrolytic capacitor	470 μF; 10 V		2222 031 34471
C14, C15, C16	multilayer ceramic chip capacitor; note 1	10 nF		
L1	stripline; note 2		length 28.5 mm width 0.93 mm	
L2	stripline; note 2		length 2.3 mm width 0.93 mm	
L3	stripline; note 2		length 3.1 mm width 0.93 mm	
L4	stripline; note 2		length 3.3 mm width 0.93 mm	
L5	stripline; note 2		length 16.3 mm width 0.93 mm	
L6	stripline; note 2		length 10 mm width 0.93 mm	
L7	stripline; note 2		length 4.4 mm width 0.4 mm	
L8	stripline; note 2		length 19.3 mm width 0.93 mm	
L9	stripline; note 2		length 19.7 mm width 0.4 mm	
L10	micro choke			
T1	BD228			
R1	metal film resistor	20 Ω; 0.4 W		2322 157 10209
R2	metal film resistor	530 Ω; 0.4 W		2322 157 15301

Notes

1. American Technical Ceramics (ATC) capacitor, type 100A or other capacitor of the same quality.
2. The striplines are on a $\frac{1}{32}$ inch double copper-clad printed-circuit board with PTFE fibre-glass dielectric ($\varepsilon_r = 6$).

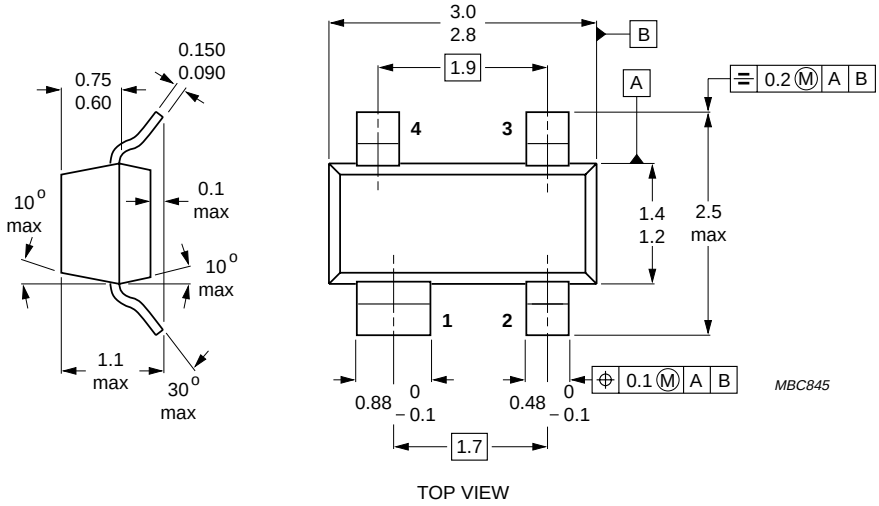


Dimensions in mm.

The components are situated on one side of the copper-clad PTFE microfibre-glass board, the other side is not etched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.8 Printed-circuit board and component lay-out for common-emitter test circuit in Fig.7.

PACKAGE OUTLINE



Dimensions in mm.

Fig.9 SOT143.

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Revision history

Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFG10X_N_5	20071122	Product data sheet	-	BFG10X_4
Modifications:	• Marking table on page 2; changed code			
BFG10X_4	19950831	Product specification	-	BFG10X_3
BFG10X_3	19950307	-	-	BFG10X_2
BFG10X_2	-	-	-	BFG10X_1
BFG10X_1	-	-	-	-

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